## Notice of References Cited Application/Control No. 10/591,948 Examiner DIEM TRAN Applicant(s)/Patent Under Reexamination MATSUNO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,622,480	09-2003	Tashiro et al.	60/295
*	В	US-6,722,120	04-2004	Plote, Holger	60/276
*	С	US-6,735,941	05-2004	Saito et al.	60/295
*	D	US-6,928,809	08-2005	Inoue et al.	60/297
*	Е	US-7,147,693	12-2006	Inoue et al.	95/273
*	F	US-7,264,642	09-2007	Hamahata et al.	55/282.3
	G	US-			
	Η	US-		ji	
	ı	US-	•		
	J	US-			
	K	US-			
	Ĺ	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
-	Q					-
	R					
	s					
	- 1					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.